



PHC2300

Complementary enhancement mode MOS transistors

Rev. 05 — 24 February 2011

Product data sheet

1. Product profile

1.1 General description

One N-channel and one P-channel enhancement mode Field-Effect Transistor (FET) in a plastic package. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

- Suitable for high frequency applications due to fast switching characteristics

1.3 Applications

- High-speed line drivers
- Line transformer drivers
- Relay drivers
- Universal line interface in telephone sets

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25\text{ °C}; T_j \leq 150\text{ °C};$ N-channel	-	-	300	V
		$T_j \geq 25\text{ °C}; T_j \leq 150\text{ °C};$ P-channel	-	-	-300	V
I_D	drain current	$T_{sp} = 80\text{ °C};$ N-channel	[1]	-	340	mA
		$T_{sp} = 80\text{ °C};$ P-channel	[1]	-	-235	mA
P_{tot}	total power dissipation	$T_{sp} = 80\text{ °C}$	[2]	-	1.6	W
Static characteristics						
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 170\text{ mA};$ $T_j = 25\text{ °C};$ N-channel	-	-	6	Ω
		$V_{GS} = -10\text{ V}; I_D = -115\text{ mA};$ $T_j = 25\text{ °C};$ P-channel	-	-	17	Ω



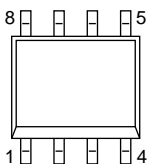
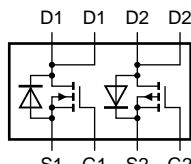
Table 1. Quick reference data ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Dynamic characteristics						
Q _{GD}	gate-drain charge	V _{GS} = -10 V; I _D = -115 mA; V _{DS} = -50 V; T _j = 25 °C; P-channel	-	674	-	pC
		V _{GS} = 10 V; I _D = 170 mA; V _{DS} = 50 V; T _j = 25 °C; N-channel	-	1385	-	pC

- [1] Solder point temperature is the temperature at the soldering point of the drain leads.
- [2] Maximum permissible dissipation per MOS transistor (both devices may thus be loaded up to 1.6 W at the same time).

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1	 <p>SOT96-1 (SO8)</p>	 <p>sym114</p>
2	G1	gate1		
3	S2	source2		
4	G2	gate2		
5	D2	drain2		
6	D2	drain2		
7	D1	drain1		
8	D1	drain1		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PHC2300	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1

4. Limiting values

Table 4. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C; N-channel	-	300	V
		T _j ≥ 25 °C; T _j ≤ 150 °C; P-channel	-	-300	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	T _{sp} = 80 °C; N-channel	[1]	340	mA
		T _{sp} = 80 °C; P-channel	[1]	-235	mA
I _{DM}	peak drain current	T _{sp} = 25 °C; pulsed; N-channel	[2]	1.4	A
		T _{sp} = 25 °C; pulsed; P-channel	[2]	-0.9	A
P _{tot}	total power dissipation	T _{sp} = 80 °C	[3]	1.6	W
		T _{amb} = 25 °C	[4]	1.8	W
		T _{amb} = 25 °C	[5]	0.9	W
		T _{amb} = 25 °C	[6]	1.2	W
T _{stg}	storage temperature		-55	150	°C
T _j	junction temperature		-55	150	°C

- [1] Solder point temperature is the temperature at the soldering point of the drain leads.
- [2] Pulse width and duty cycle limited by maximum junction temperature.
- [3] Maximum permissible dissipation per MOS transistor (both devices may thus be loaded up to 1.6 W at the same time).
- [4] Maximum permissible dissipation per MOS transistor. Value based on a printed-circuit board with an R_{th(a-tp)} (ambient to tie-point) of 27.5 K/W.
- [5] Maximum permissible dissipation per MOS transistor. Value based on a printed-circuit board with an R_{th(a-tp)} (ambient to tie-point) of 90 K/W.
- [6] Maximum permissible dissipation if only one MOS transistor dissipates. Value based on a printed-circuit board with an R_{th(a-tp)} (ambient to tie-point) of 90 K/W.

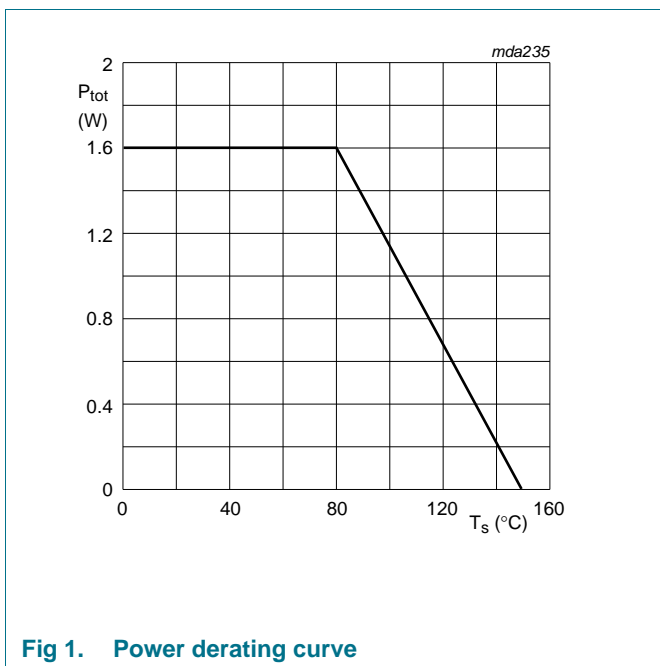


Fig 1. Power derating curve

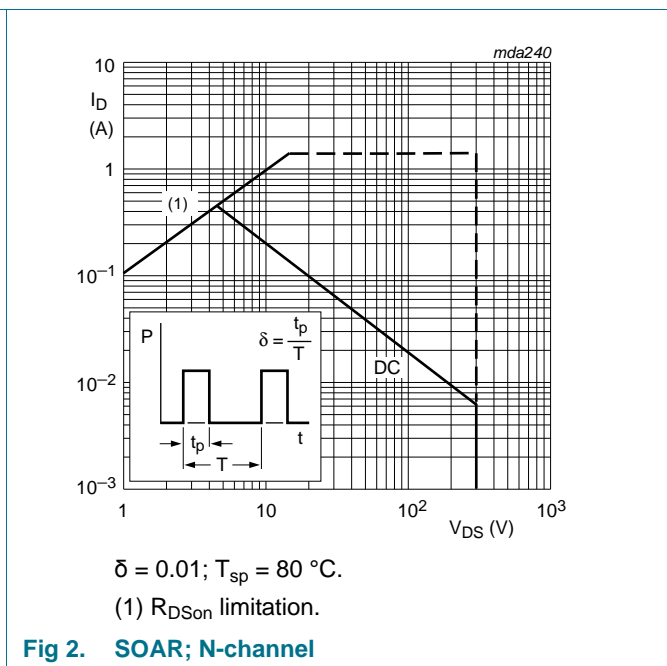
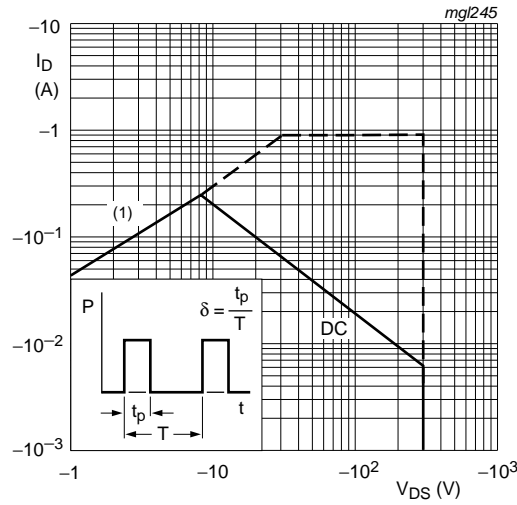


Fig 2. SOAR; N-channel



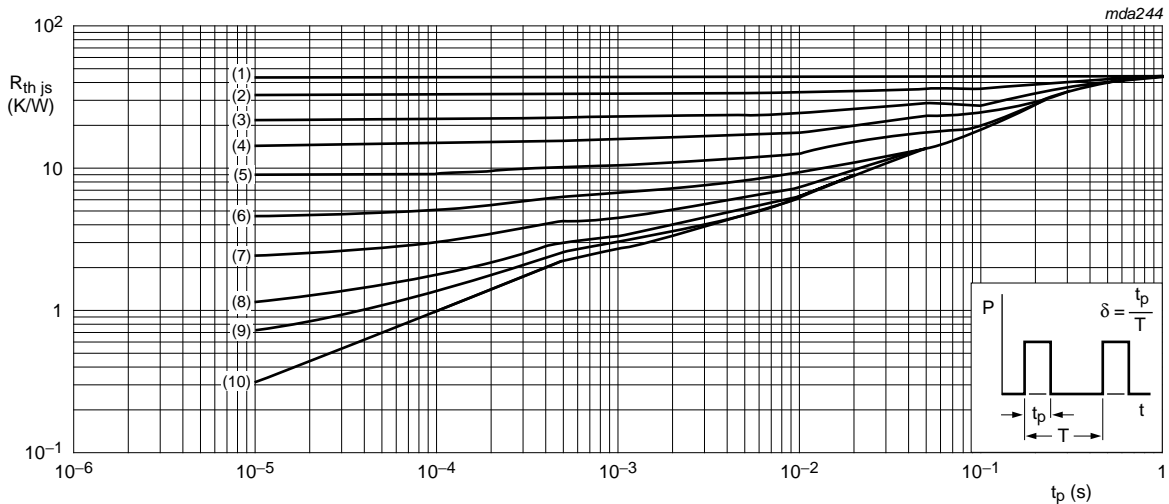
$\delta = 0.01$; $T_{sp} = 80\text{ }^{\circ}\text{C}$.
 (1) R_{DSon} limitation.

Fig 3. SOAR; P-channel

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	43	K/W



(1) $\delta = 1.00$. (2) $\delta = 0.75$. (3) $\delta = 0.5$. (4) $\delta = 0.33$. (5) $\delta = 0.2$.
 (6) $\delta = 0.1$. (7) $\delta = 0.05$. (8) $\delta = 0.02$. (9) $\delta = 0.01$. (10) $\delta = 0$.

Fig 4. Transient thermal resistance from junction to soldering point as a function of pulse time for N- and P-channel; typical values

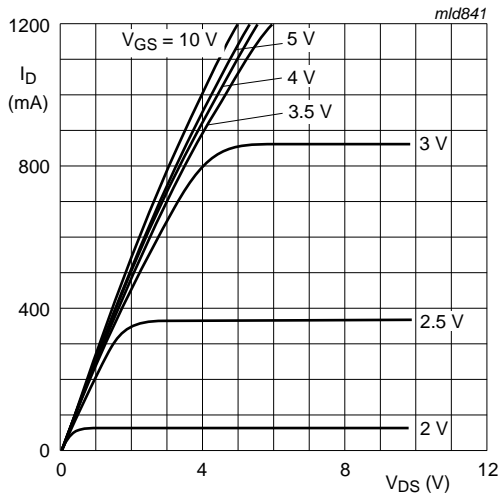
6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -10 \mu\text{A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-300	-	-	V
		$I_D = 10 \mu\text{A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	300	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	0.8	-	2	V
		$I_D = -1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-0.8	-	-2	V
I_{DSS}	drain leakage current	$V_{DS} = -240 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	-	-100	nA
		$V_{DS} = 240 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	-	100	nA
I_{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	-	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	-	100	nA
		$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	-	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 170 \text{ mA}; T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	-	6	Ω
		$V_{GS} = -10 \text{ V}; I_D = -115 \text{ mA}; T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	-	17	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 170 \text{ mA}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	6240	-	pC
		$I_D = -115 \text{ mA}; V_{DS} = -50 \text{ V}; V_{GS} = -10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	2137	-	pC
Q_{GS}	gate-source charge	$I_D = 170 \text{ mA}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	226	-	pC
		$I_D = -115 \text{ mA}; V_{DS} = -50 \text{ V}; V_{GS} = -10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	68	-	pC
Q_{GD}	gate-drain charge	$T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	674	-	pC
		$I_D = 170 \text{ mA}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	1385	-	pC
C_{iss}	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	102	-	pF
		$V_{DS} = -50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	45	-	pF
C_{oss}	output capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ }^\circ\text{C};$ N-channel	-	15	-	pF
		$V_{DS} = -50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ }^\circ\text{C};$ P-channel	-	15	-	pF

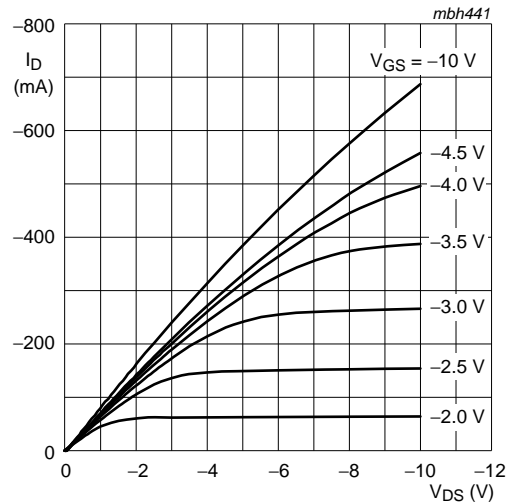
Table 6. Characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C_{rss}	reverse transfer capacitance	$V_{DS} = 50\text{ V}; V_{GS} = 0\text{ V}; f = 1\text{ MHz}; T_j = 25\text{ }^\circ\text{C}; \text{N-channel}$	-	7.3	-	pF
		$V_{DS} = -50\text{ V}; V_{GS} = 0\text{ V}; f = 1\text{ MHz}; T_j = 25\text{ }^\circ\text{C}; \text{P-channel}$	-	3	-	pF
t_{on}	turn-on time	$V_{DS} = 50\text{ V}; V_{GS} = 10\text{ V}; I_D = 170\text{ mA}; T_j = 25\text{ }^\circ\text{C}; \text{N-channel}$	-	7	12	ns
		$V_{DS} = -50\text{ V}; V_{GS} = -10\text{ V}; I_D = -115\text{ mA}; T_j = 25\text{ }^\circ\text{C}; \text{P-channel}$	-	4	10	ns
t_{off}	turn-off time	$V_{DS} = 50\text{ V}; V_{GS} = 10\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_D = 170\text{ mA}; \text{N-channel}$	-	53	65	ns
		$V_{DS} = -50\text{ V}; V_{GS} = -10\text{ V}; T_j = 25\text{ }^\circ\text{C}; I_D = -115\text{ mA}; \text{P-channel}$	-	25	35	ns



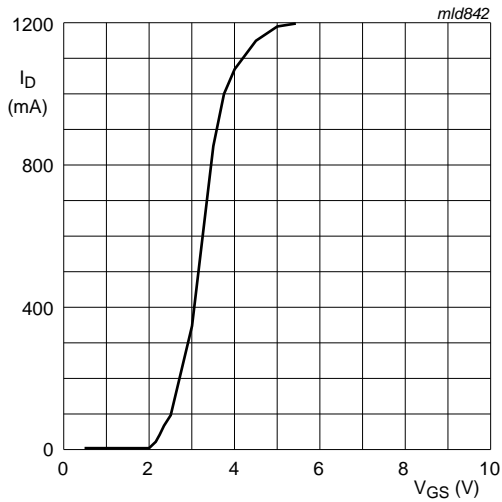
$T_{amb} = 25\text{ }^\circ\text{C}; t_p = 80\text{ }\mu\text{s}; \delta = 0.$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; N-channel; typical values



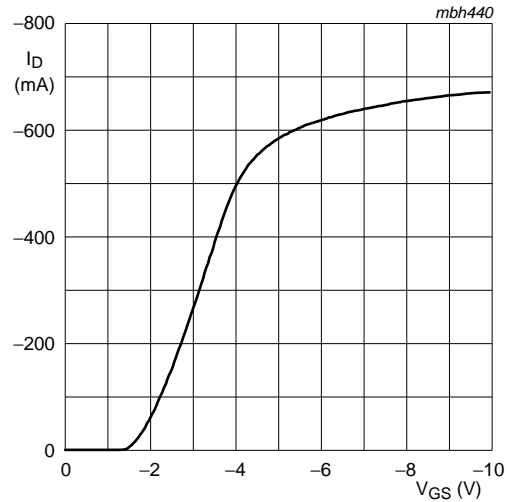
$T_{amb} = 25\text{ }^\circ\text{C}; t_p = 80\text{ }\mu\text{s}; \delta = 0.$

Fig 6. Output characteristics: drain current as a function of drain-source voltage; P-channel; typical values



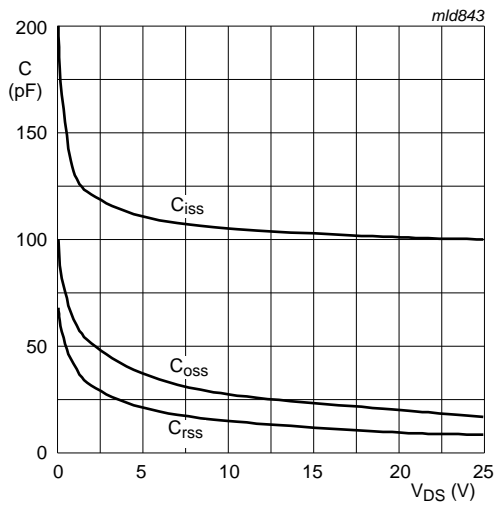
$V_{DS} = 10\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}; t_p = 80\text{ }\mu\text{s}; \delta = 0.$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; N-channel; typical values



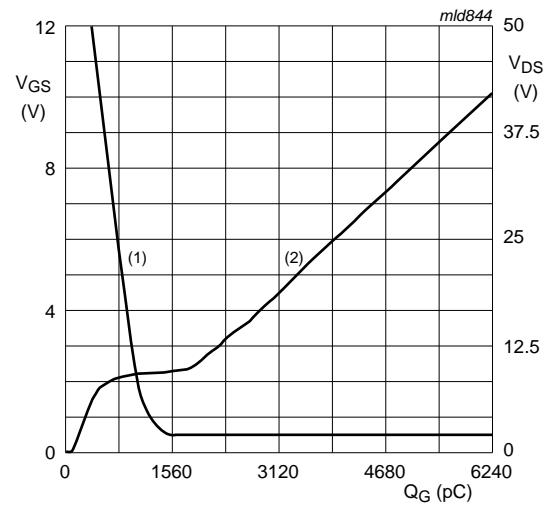
$V_{DS} = -10\text{ V}; T_{amb} = 25\text{ }^{\circ}\text{C}; t_p = 80\text{ }\mu\text{s}; \delta = 0.$

Fig 8. Transfer characteristics: drain current as a function of gate-source voltage; P-channel; typical values



$T_{amb} = 25\text{ }^{\circ}\text{C}; f = 1\text{ MHz}$

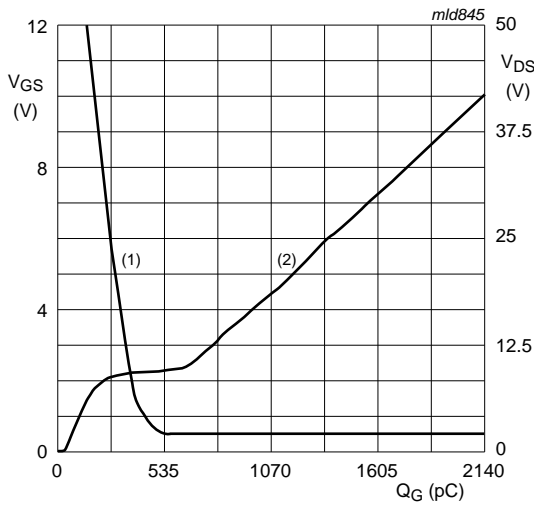
Fig 9. Input, output and reverse transfer capacitances as a function of drain-source voltage; N-channel; typical values



$V_{DS} = 50\text{ V}; I_D = 170\text{ mA}; T_{amb} = 25\text{ }^{\circ}\text{C}.$

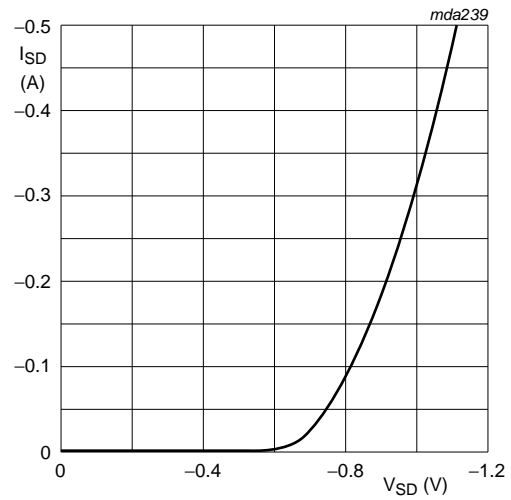
(1) V_{DS}
(2) V_{GS}

Fig 10. Gate-source voltage and drain-source voltage as a function of gate charge; N-channel typical values



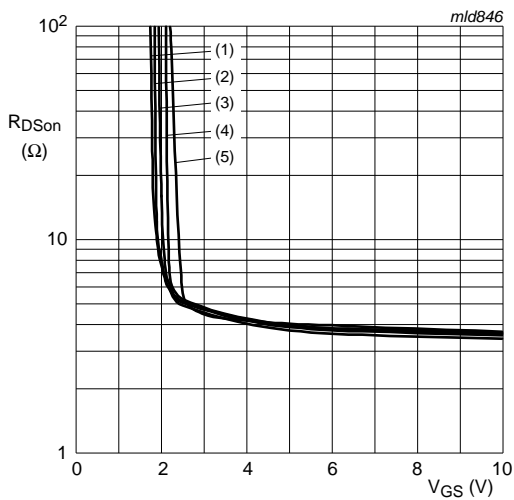
V_{DS} = -50 V; I_D = -115 mA; T_{amb} = 25 °C.
 (1) V_{DS}
 (2) V_{GS}

Fig 11. Gate-source voltage and drain-source voltage as a function of gate charge; P-channel typical values



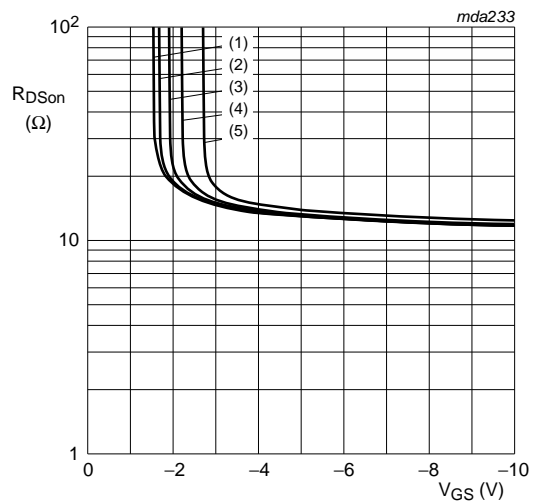
V_{GD} = 0V

Fig 12. Source current as a function of source-drain voltage; P-channel typical values



V_{DS} ≥ I_D × R_{DSon}; T_{amb} = 25 °C; t_p = 300 μs; δ = 0.
 (1) I_D = 10 mA.
 (2) I_D = 20 mA.
 (3) I_D = 50 mA.
 (4) I_D = 100 mA.
 (5) I_D = 200 mA.

Fig 13. Drain-source on-state resistance as a function of gate-source voltage; N-channel typical values



V_{DS} ≥ I_D × R_{DSon}; T_{amb} = 25 °C; t_p = 300 μs; δ = 0.
 (1) I_D = -10 mA.
 (2) I_D = -20 mA.
 (3) I_D = -50 mA.
 (4) I_D = -100 mA.
 (5) I_D = -200 mA.

Fig 14. Drain-source on-state resistance as a function of gate-source voltage; P-channel typical values

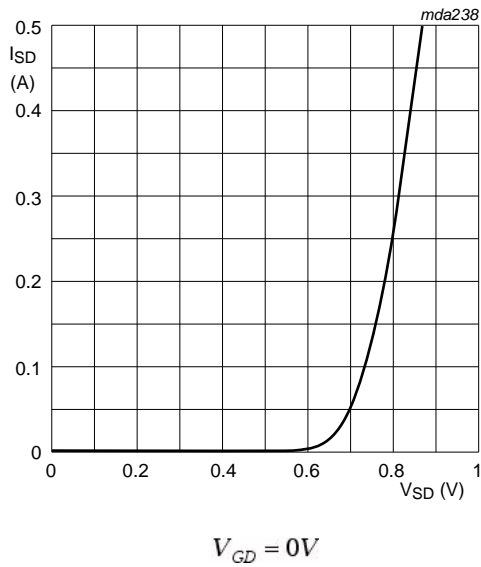


Fig 15. Source-drain current as a function of source-drain diode voltage; N-channel; typical values

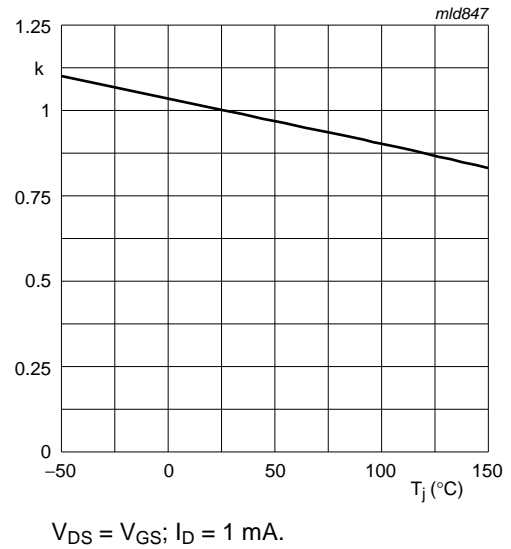


Fig 16. Temperature coefficient of gate-source threshold voltage as a function temperature; N-channel; typical values

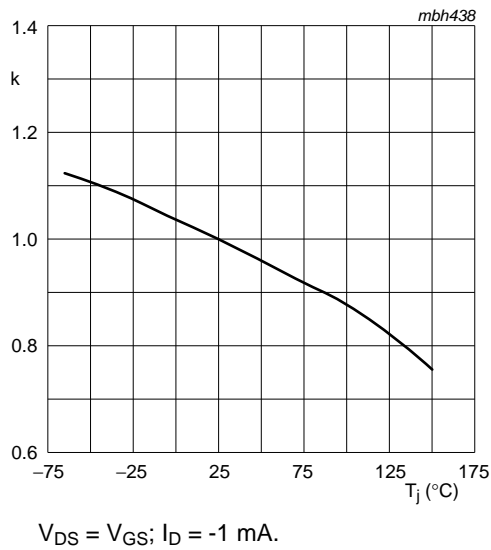


Fig 17. Temperature coefficient of gate-source threshold voltage as a function temperature; P-channel; typical values

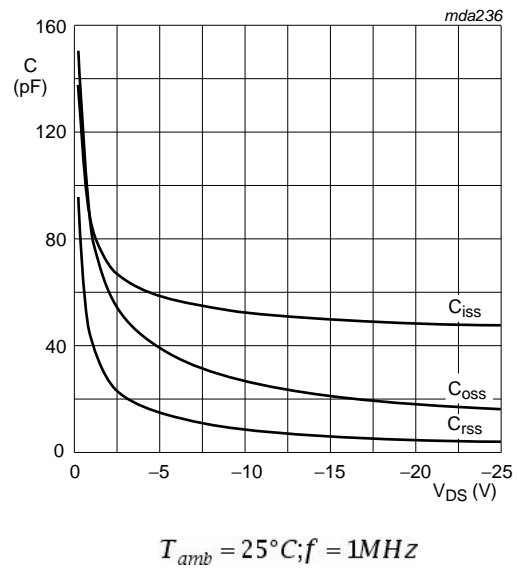


Fig 18. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1

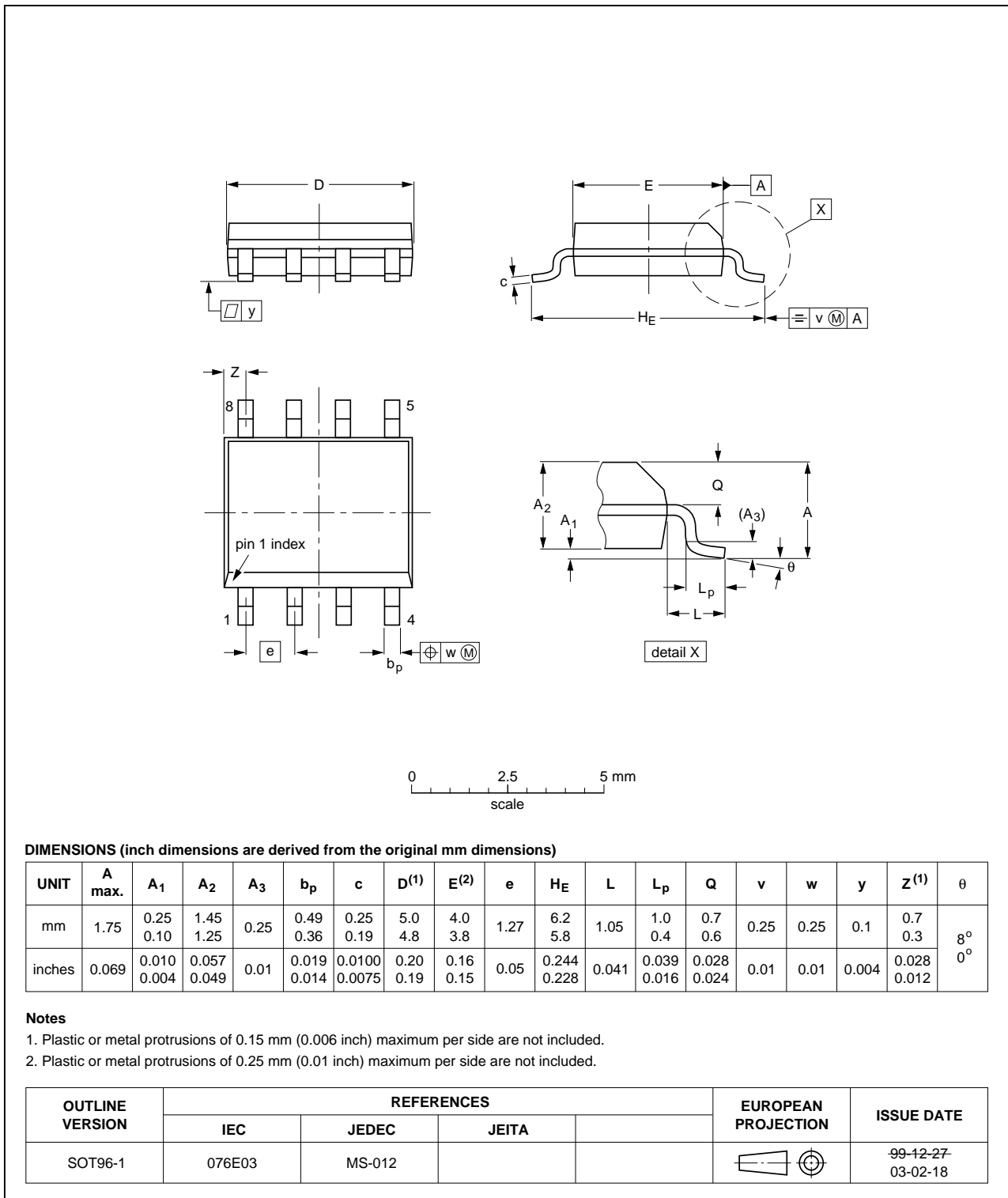


Fig 19. Package outline SOT96-1 (SO8)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PHC2300 v.5	20110224	Product data sheet	-	PHC2300 v.4
Modifications:	• Various changes to content.			
PHC2300 v.4	20101216	Product data sheet	-	PHC2300 v.3

9. Legal information

9.1 Data sheet status

Document status ^[1] ^[2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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10. Contact information

For more information, please visit: <http://www.nxp.com>

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Date of release: 24 February 2011

Document identifier: PHC2300